



FQB34N20L / FQI34N20L

200V LOGIC N-Channel MOSFET

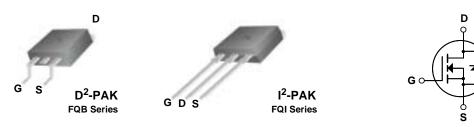
General Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switching DC/DC converters, switch mode power supply, motor control.

Features

- 31A, 200V, $R_{DS(on)} = 0.075\Omega @V_{GS} = 10 \text{ V}$
- Low gate charge (typical 55 nC)
- Low Crss (typical 52 pF)
- · Fast switching
- 100% avalanche tested
- · Improved dv/dt capability
- Low level gate drive requirement allowing direct opration from logic drivers
- · RoHS Compliant



Absolute Maximum Ratings $T_C = 25$ °C unless otherwise noted

Symbol	Parameter		FQB34N20L / FQI34N20L	Units
V _{DSS}	Drain-Source Voltage		200	V
I _D	Drain Current - Continuous (T _C = 25°C)		31	Α
	- Continuous (T _C = 100°C	;)	20	Α
I _{DM}	Drain Current - Pulsed	(Note 1)	124	Α
V _{GSS}	Gate-Source Voltage		± 20	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	640	mJ
I _{AR}	Avalanche Current	(Note 1)	31	А
E _{AR}	Repetitive Avalanche Energy	(Note 1)	18	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	5.5	V/ns
P _D	Power Dissipation (T _A = 25°C) *		3.13	W
	Power Dissipation (T _C = 25°C)		180	W
	- Derate above 25°C		1.43	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		0.7	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		40	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		62.5	°C/W

* When mounted on the minimum pad size recommended (PCB Mount)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Cha	aracteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	200			V
ΔBV _{DSS} / ΔΤ _J	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C		0.16		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 200 V, V _{GS} = 0 V			1	μΑ
		V _{DS} = 160 V, T _C = 125°C			10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 20 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -20 V, V _{DS} = 0 V			-100	nA
On Cha	aracteristics		•			
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	1.0		2.0	V
R _{DS(on)}	Static Drain-Source	V _{GS} = 10 V, I _D = 15.5 A		0.057	0.075	-
DQ(on)	On-Resistance	V _{GS} = 5 V, I _D = 15.5 A		0.060	0.080	Ω
9 _{FS}	Forward Transconductance	V _{DS} = 30 V, I _D = 15.5 A (Note 4)		41		S
C _{oss} C _{rss}	Output Capacitance Reverse Transfer Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz		400 52	520 67	pF pF
C _{rss}	Reverse Transfer Capacitance			52	67	nF
					I.	Pi
	ing Characteristics		1	ı	I	ļ Pi
t _{d(on)}	Turn-On Delay Time	V _{DD} = 100 V, I _D = 34 A,		45	100	ns
Switch t _{d(on)} t _r	Turn-On Delay Time Turn-On Rise Time	$V_{DD} = 100 \text{ V}, I_{D} = 34 \text{ A},$ $R_{G} = 25 \Omega$		520	1050	
t _{d(on)} t _r t _{d(off)}	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time	$R_G = 25 \Omega$		520 170	1050 350	ns
t _{d(on)} t _r t _{d(off)}	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time			520 170 370	1050 350 750	ns ns ns
t _{d(on)} t _r t _{d(off)} t _f Q _g	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge	$R_G = 25 \Omega$		520 170 370 55	1050 350	ns ns ns ns
t _d (on) t _r t _d (off) t _f Q _g Q _{gs}	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge	$R_G = 25 \ \Omega$ (Note 4, 5)	 	520 170 370 55 9.9	1050 350 750 72	ns ns ns ns
t _d (on) t _r t _d (off) t _f Q _g Q _{gs}	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge	$R_{G} = 25~\Omega \label{eq:RG}$ (Note 4, 5) $V_{DS} = 160~V, I_{D} = 34~A,$		520 170 370 55	1050 350 750 72	ns ns ns ns
td(on) tr tr td(off) tf Qg Qgs Qgd	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge	$R_{G} = 25~\Omega \label{eq:controller}$ (Note 4, 5) $V_{DS} = 160~V,~I_{D} = 34~A,$ $V_{GS} = 5~V \label{eq:controller}$ (Note 4, 5)	 	520 170 370 55 9.9	1050 350 750 72	ns ns ns ns
t _{d(on)} t _r t _{d(off)} t _{d(off)} t _f Q _g Q _{gs} Q _{gd}	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge	$R_G = 25~\Omega$ (Note 4, 5) $V_{DS} = 160~V, I_D = 34~A,$ $V_{GS} = 5~V$ (Note 4, 5) $\mathbf{Maximum~Ratings}$	 	520 170 370 55 9.9	1050 350 750 72	ns ns ns ns
td(on) tr td(off) tf Qg Qgs Qgd Drain-S	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge	$R_{G} = 25 \ \Omega$ (Note 4, 5) $V_{DS} = 160 \ V, \ I_{D} = 34 \ A,$ $V_{GS} = 5 \ V$ (Note 4, 5) $N_{GS} = 100 \ V = 100 \ V_{OS} = 100 \ V = 100 \ V_{OS} =$	 	520 170 370 55 9.9 27	1050 350 750 72 	ns ns ns ns nC nC
$egin{array}{l} t_{d(on)} \\ t_r \\ t_{d(off)} \\ t_f \\ Q_g \\ Q_{gs} \\ Q_{gd} \\ \hline egin{array}{c} \mathbf{Drain-S} \\ I_{SM} \\ \hline \end{array}$	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge Source Diode Characteristics and Maximum Continuous Drain-Source Diode	$R_{G} = 25 \ \Omega$ (Note 4, 5) $V_{DS} = 160 \ V, \ I_{D} = 34 \ A,$ $V_{GS} = 5 \ V$ (Note 4, 5) $N_{GS} = 100 \ V = 100 \ V_{OS} = 100 \ V = 100 \ V_{OS} =$	 	520 170 370 55 9.9 27	1050 350 750 72 	ns ns ns ns nC nC
t _{d(on)} t _r t _r t _{d(off)} t _f Q _g Q _{gs} Q _{gd}	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge Source Diode Characteristics at Maximum Continuous Drain-Source Diode Maximum Pulsed Drain-Source Diode F	$R_{G} = 25 \ \Omega$ $V_{DS} = 160 \ V, \ I_{D} = 34 \ A,$ $V_{GS} = 5 \ V$ (Note 4, 5) Ad Maximum Ratings ode Forward Current	 	520 170 370 55 9.9 27	1050 350 750 72 31 124	ns ns ns ns nC nC nC

Typical Characteristics

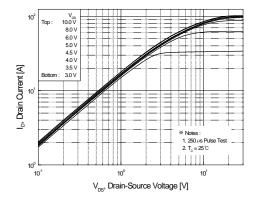


Figure 1. On-Region Characteristics

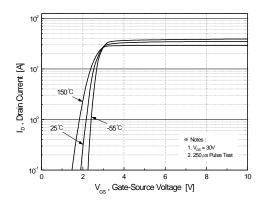


Figure 2. Transfer Characteristics

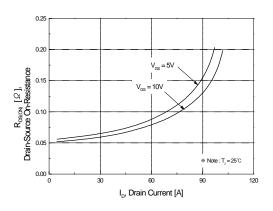


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

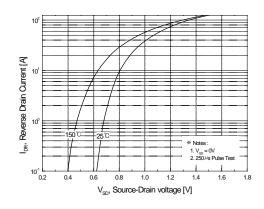


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

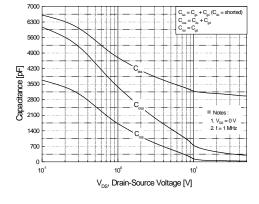


Figure 5. Capacitance Characteristics

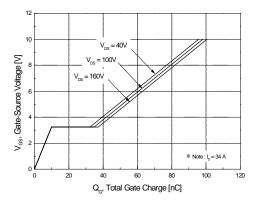
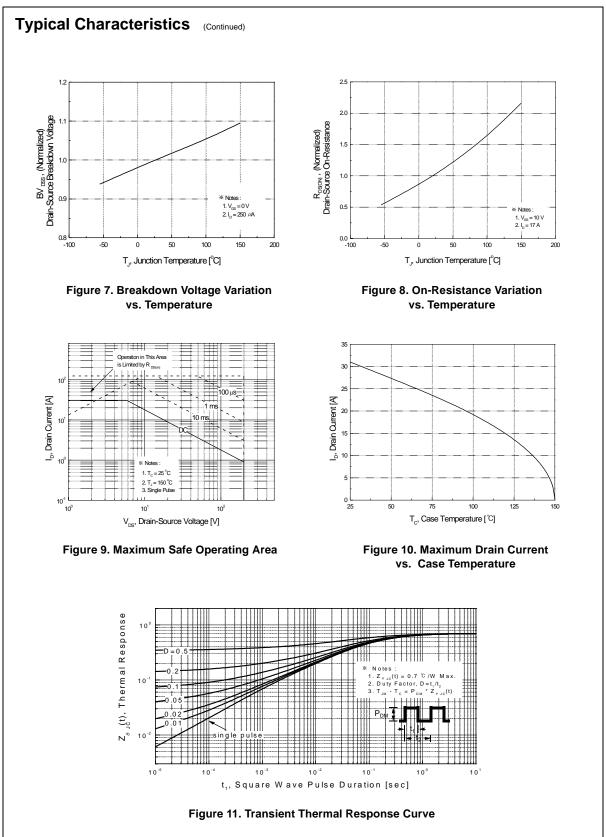


Figure 6. Gate Charge Characteristics

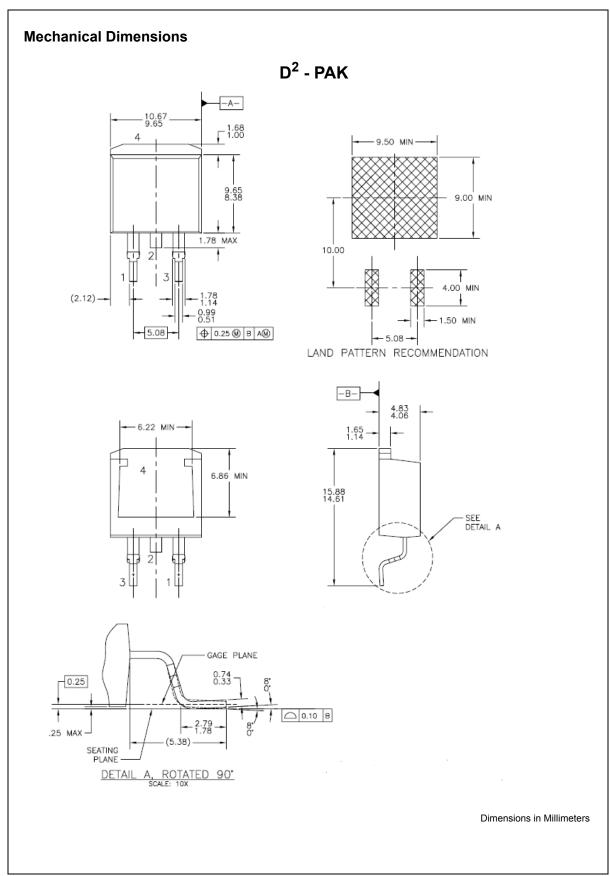


Gate Charge Test Circuit & Waveform V_{GS} Same Type as DUT 5V ➡ VDS DUT Charge **Resistive Switching Test Circuit & Waveforms** DUT 5∨ ∏ **Unclamped Inductive Switching Test Circuit & Waveforms** $\mathsf{BV}_{\mathsf{DSS}}$ I_{AS} V_{DD} $I_D(t)$ $V_{DS}(t)$ DUT V_{DD} Time

Peak Diode Recovery dv/dt Test Circuit & Waveforms DUT I_{SD o} Driver Same Type as DUT V_{DD} • dv/dt controlled by R_G • I_{SD} controlled by pulse period Gate Pulse Width V_{GS} Gate Pulse Period 10V (Driver) I_{FM} , Body Diode Forward Current \mathbf{I}_{SD} di/dt (DUT) I_{RM} **Body Diode Reverse Current** V_{DS} (DUT) Body Diode Recovery dv/dt

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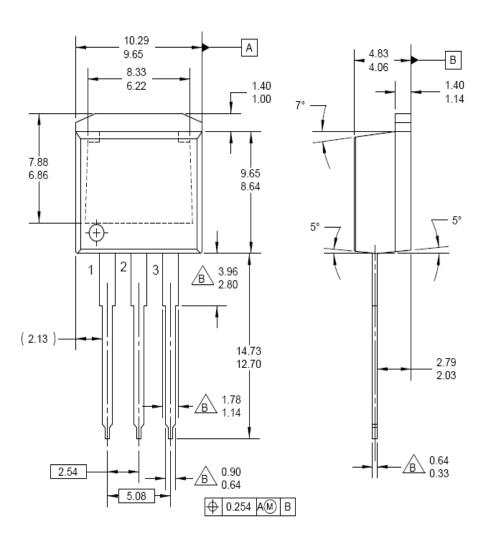
Body Diode Forward Voltage Drop



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Mechanical Dimensions

I² - PAK



Dimensions in Millimeters





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